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# MOSFET – Power, Dual, N-Channel with Integrated Schottky, SO8FL

## 30 V, High Side 18 A / Low Side 23 A

#### **Features**

- Co-Packaged Power Stage Solution to Minimize Board Space
- Low Side MOSFET with Integrated Schottky
- Minimized Parasitic Inductances
- Optimized Devices to Reduce Power Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

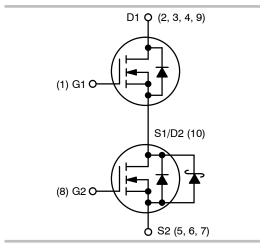
- DC-DC Converters
- System Voltage Rails
- Point of Load



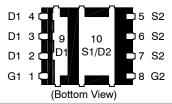
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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
Q1 Top FET	6.5 mΩ @ 10 V	10 /
30 V	10 mΩ @ 4.5 V	18 A
Q2 Bottom	4.1 mΩ @ 10 V	00.4
FET 30 V	6.2 mΩ @ 4.5 V	23 A



#### **PIN CONNECTIONS**



#### MARKING DIAGRAM



DFN8 CASE 506BX



4902NF = Specific Device Code A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

## **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter		Symbol	Value	Unit			
Drain-to-Source Voltage	Q1	V <sub>DSS</sub>	30	V			
Drain-to-Source Voltage	Q2						
Gate-to-Source Voltage			Q1	V <sub>GS</sub>	±20	V	
Gate-to-Source Voltage			Q2				
Continuous Drain Current R <sub>0JA</sub> (Note 1)		T <sub>A</sub> = 25°C	Q1	I <sub>D</sub>	13.5		
		T <sub>A</sub> = 85°C	1		9.7	1 .	
		T <sub>A</sub> = 25°C	Q2		17.5	A	
		T <sub>A</sub> = 85°C	1		12.6	]	
Power Dissipation	1	T <sub>A</sub> = 25°C	Q1	$P_{D}$	1.90	W	
RθJA (Note 1)			Q2		1.99	]	
Continuous Drain Current $R_{\theta JA} \le 10 \text{ s (Note 1)}$	1	T <sub>A</sub> = 25°C	Q1	I <sub>D</sub>	18.2		
		T <sub>A</sub> = 85°C	1		13.1	1 .	
	Steady	T <sub>A</sub> = 25°C	Q2		23	A	
	State	T <sub>A</sub> = 85°C	1		16.6		
Power Dissipation	1	T <sub>A</sub> = 25°C	Q1	$P_{D}$	3.45	W	
R <sub>θJA</sub> ≤ 10 s (Note 1)			Q2		3.45		
Continuous Drain Current		T <sub>A</sub> = 25°C	Q1	I <sub>D</sub>	10.3		
R <sub>0JA</sub> (Note 2)		T <sub>A</sub> = 85°C	1		7.4	1 .	
		T <sub>A</sub> = 25°C	Q2		13.3	A	
		T <sub>A</sub> = 85°C	1		9.6		
Power Dissipation		T <sub>A</sub> = 25 °C	Q1	$P_{D}$	1.10	W	
R <sub>θJA</sub> (Note 2)			Q2		1.16		
Pulsed Drain Current	•	TA = 25°C	Q1	I <sub>DM</sub>	60	Α	
		tp = 10 μs	Q2		80		
Operating Junction and Storage Temperature		•	Q1	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C	
			Q2				
Source Current (Body Diode)	Q1	I <sub>S</sub>	3.4	Α			
			Q2		4.9	1	
Drain to Source dV/dt		dV/dt	6.0	V/ns			
Single Pulse Drain-to-Source Avalanche Energy (TJ	= 25C,	24 A	Q1	EAS	28.8	mJ	
$V_{DD} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_L = XX A_{pk}, L = 0.1 \text{ mH}, R_{G}$	<sub>i</sub> = 25 Ω)	27 A	Q2	EAS	36.5	1	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T <sub>L</sub>	260	°C			

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.

2. Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm<sup>2</sup>.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	FET	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 3)	Q1	$R_{\theta JA}$	65.9	
	Q2		62.8	
Junction-to-Ambient - Steady State (Note 4)	Q1	$R_{\theta JA}$	113.2	0000
	Q2		108	°C/W
Junction-to-Ambient - (t ≤ 10 s) (Note 3)	Q1	$R_{\theta JA}$	36.2	
	Q2		36.2	

- 3. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm<sup>2</sup>.

## **ELECTRICAL CHARACTERISTICS** (T<sub>.1</sub> = 25°C unless otherwise specified)

Parameter	FET	Symbol	Test Co	ondition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				•			•
Drain-to-Source Break-	Q1	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V,	I <sub>D</sub> = 250 μA	30			V
down Voltage	Q2		V <sub>GS</sub> = 0 V,	I <sub>D</sub> = 1.0 mA	30			
Drain-to-Source Break-	Q1	V <sub>(BR)DSS</sub>				18		mV /
down Voltage Temperature Coefficient	Q2	. / T <sub>J</sub>				15		°C
Zero Gate Voltage Drain	Q1	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1	μΑ
Current			$V_{DS} = 24 \text{ V}$	T <sub>J</sub> = 125°C			10	
	Q2		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 25°C			500	
Gate-to-Source Leakage	Q1	I <sub>GSS</sub>	V <sub>GS</sub> = 0 V, \	VDS = ±20 V			±100	nA
Current	Q2						±100	1
ON CHARACTERISTICS (Not	e 5)				•	•		
Gate Threshold Voltage	Q1	V <sub>GS(TH)</sub>	$V_{GS}$ = VDS, $I_D$ = 250 $\mu$ A		1.2		2.2	V
	Q2				1.2		2.2	1
Negative Threshold Temper-	Q1	V <sub>GS_(TH)</sub> /				4.5		mV /
ature Coefficient	Q2	TJ				4.0		°C
Drain-to-Source On Resist-	Q1	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 10 A		5.2	6.5	
ance			V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 10 A		8.0	10	
	Q2		V <sub>GS</sub> = 10 V	I <sub>D</sub> = 15 A		3.3	4.1	mΩ
			V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 15 A		5.0	6.2	
Forward Transconductance	Q1	9FS	V <sub>DS</sub> = 1.5	V, I <sub>D</sub> = 10 A		28		S
	Q2					35		
CHARGES, CAPACITANCES	& GATE	RESISTANCI	E					
	Q1					1150		
Input Capacitance	Q2	Q2 C <sub>ISS</sub>				1590		]
Output Conscitones	Q1	Coss V	V 0V/f 4	$V_{GS}$ = 0 V, f = 1 MHz, $V_{DS}$ = 15 V		360		
Output Capacitance	Q2		$v_{GS} = 0 \text{ V, } t = 1$			813		pF
Deveres Consolitance	Q1					105		1
Reverse Capacitance	02	C <sub>RSS</sub>				83		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

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- 6. Switching characteristics are independent of operating junction temperatures.

Q2

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	FET	Symbol	Test Co	ondition	Min	Тур	Max	Unit
CHARGES, CAPACITANCES	& GATE	RESISTANC	E		-	-	-	-
	Q1					9.7		
Total Gate Charge	Q2	Q <sub>G(TOT)</sub>				11.5		
	Q1	_				1.1		
Threshold Gate Charge	Q2	Q <sub>G(TH)</sub>				1.4		
	Q1		$V_{GS}$ = 4.5 V, $V_{DS}$	= 15 V; I <sub>D</sub> = 10 A		3.3		nC
Gate-to-Source Charge	Q2	Q <sub>GS</sub>				4.2		
	Q1				3.7			
Gate-to-Drain Charge	Q2	$Q_GD$				3.4		
Total Gate Charge	Q1					19.1		
	Q2	Q <sub>G(TOT)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 10 \text{ A}$		24.9		nC	
SWITCHING CHARACTERIS	STICS (No	te 6)			1	I .	l .	<u>I</u>
	Q1					9.0		
Turn-On Delay Time	Q2	t <sub>d(ON)</sub>				10.5		1
Rise Time	Q1	- t <sub>r</sub>				15		†
	Q2		V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V,			15.2		1
Turn-Off Delay Time	Q1		$I_{\rm D} = 10  \rm A,  l$	$R_G = 3.0 \Omega$		14		ns
	Q2	t <sub>d(OFF)</sub>				17.7		
	Q1					4.0		
Fall Time	Q2	t <sub>f</sub>				4.7		1
SWITCHING CHARACTERIS	STICS (No	te 6)			ı		ı	
	Q1					6.0		Τ
Turn-On Delay Time	Q2	t <sub>d(ON)</sub>				7.0		
	Q1					14		
Rise Time	Q2	· t <sub>r</sub>	V 40VV 45V			14		
	Q1		$V_{GS} = 10 \text{ V},$ $I_D = 10 \text{ A},$	$N_{DS} = 10 \text{ V},$ $R_{G} = 3.0 \Omega$		17		ns
Turn-Off Delay Time	Q2	t <sub>d(OFF)</sub>	5			22		-
Fall Time	Q1					3.0		
	Q2	t <sub>f</sub>			3.3		1	
DRAIN-SOURCE DIODE CH		RISTICS			1		l	<u> </u>
	1	<u> </u>	V 0V	T <sub>J</sub> = 25°C		0.75	1.0	
			$V_{GS} = 0 \text{ V},$ $I_{S} = 3 \text{ A}$	J =		ļ		-
	Q1		$I_S = 3 A$	T <sub>1</sub> = 125°C		0.62		
Forward Voltage	Q1	· V <sub>SD</sub>	$I_S = 3 A$ $V_{GS} = 0 V$	$T_J = 125^{\circ}C$ $T_J = 25^{\circ}C$	+	0.62 0.37	0.70	٧

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ . 6. Switching characteristics are independent of operating junction temperatures.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CH	ARACTE	RISTICS					
D	Q1				23		
Reverse Recovery Time	Q2	t <sub>RR</sub>			24.5		- - ns
Chausa Tima	Q1				12		
Charge Time	Q2	ta	$V_{GS}$ = 0 V, $d_{IS}/d_t$ = 100 A/ $\mu$ s, $I_S$ = 3 A		13		
District Tree	Q1	tb			11		
Discharge Time	Q2				11.5		
D D Ol	Q1	- Q <sub>RR</sub>			12		nC
Reverse Recovery Charge	Q2				24		
PACKAGE PARASITIC VALU	ES						
Course ladueters	Q1				0.38		nH
Source Inductance	Q2	L <sub>S</sub>			0.65		
Darie Leilanderen	Q1				0.054		T
Drain Inductance	Q2	L <sub>D</sub>			0.007		nH
Oala lada da aa	Q1		-G		1.5		-11
Gate Inductance	Q2	L <sub>G</sub>			1.5		nH
Oala Basisla a a	Q1	-			0.8		
Gate Resistance	Q2	$R_{G}$			0.8		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFD4902NFT1G	DFN8 (Pb-Free)	1500 / Tape & Reel
NTMFD4902NFT3G	DFN8 (Pb-Free)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

<sup>6.</sup> Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS - Q1**

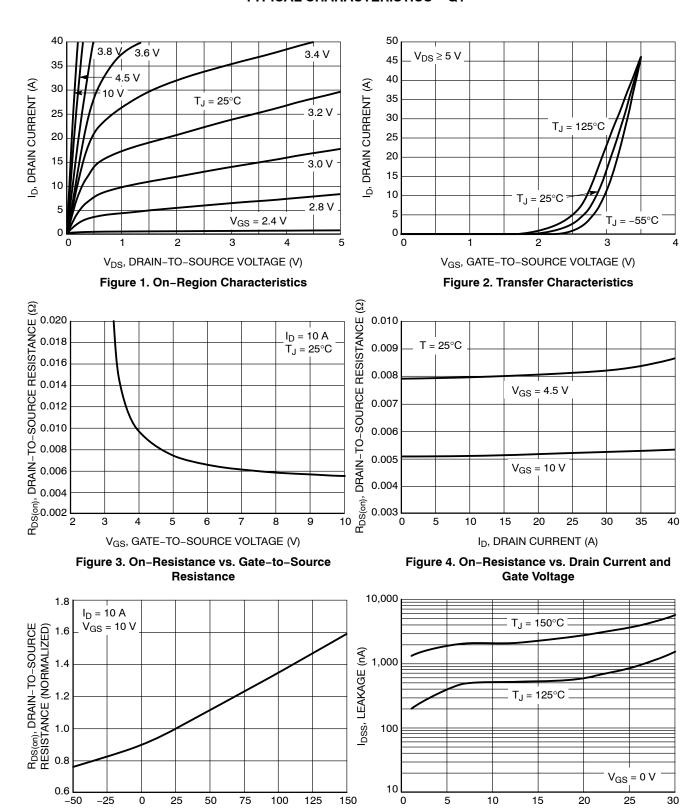


Figure 5. On–Resistance Variation with Temperature

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

## **TYPICAL CHARACTERISTICS - Q1**

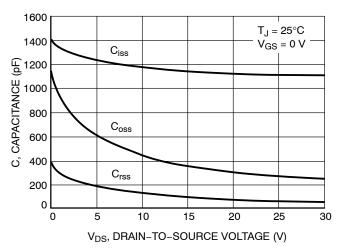


Figure 7. Capacitance Variation

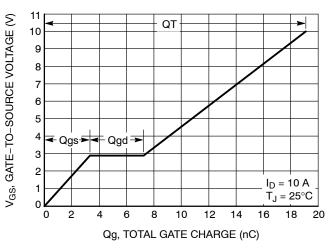


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

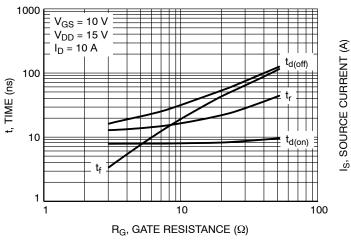


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

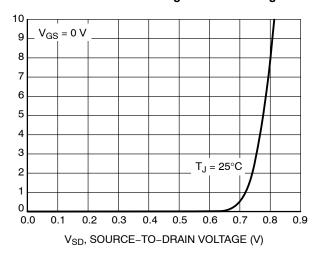


Figure 10. Diode Forward Voltage vs. Current

#### **TYPICAL CHARACTERISTICS - Q2**

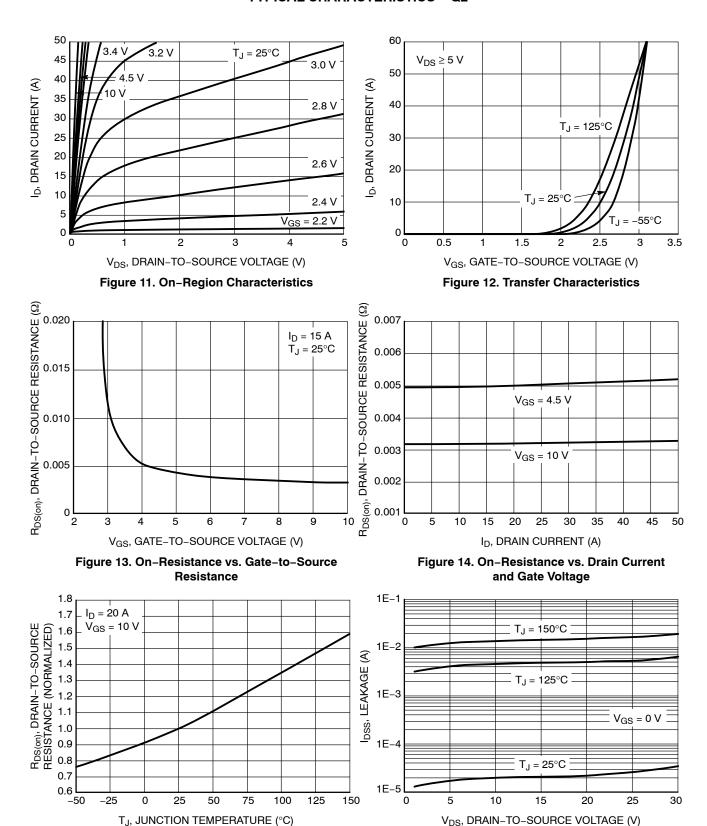


Figure 16. Drain-to-Source Leakage Current

vs. Voltage

Figure 15. On-Resistance Variation with

**Temperature** 

## **TYPICAL CHARACTERISTICS - Q2**

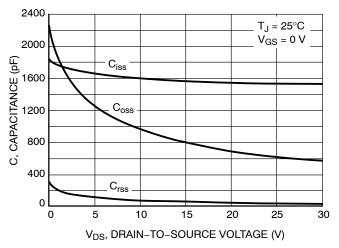


Figure 17. Capacitance Variation

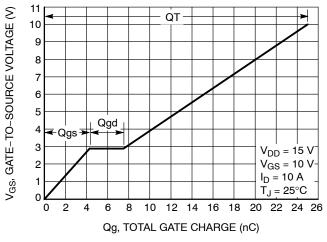


Figure 18. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

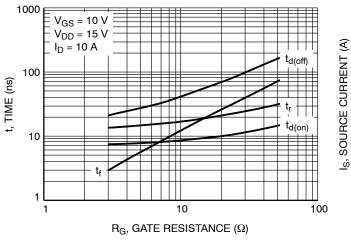


Figure 19. Resistive Switching Time Variation vs. Gate Resistance

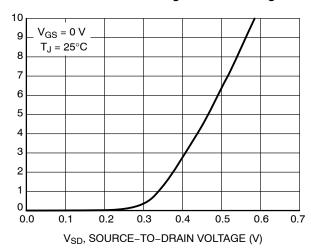
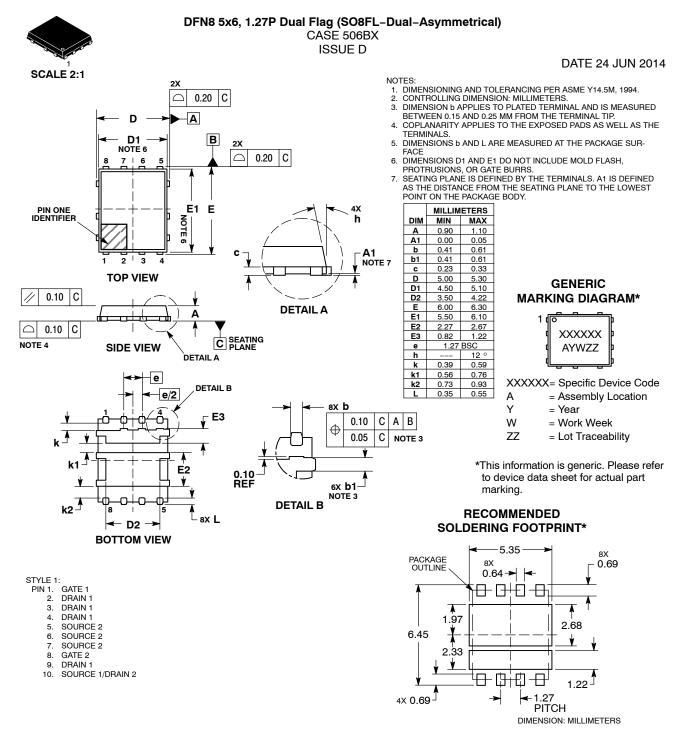


Figure 20. Diode Forward Voltage vs. Current



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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